

<b>Notice of References Cited</b>	Application/Control No. 10/729,841	Applicant(s)/Patent Under Reexamination SAMJI ET AL.	
	Examiner Anh Ly	Art Unit 2162	Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0255048	12-2004	Lev Ran et al.	709/249
*	B	US-2004/0003247	01-2004	Fraser et al.	713/169
*	C	US-2002/0052885	05-2002	Levy, Kenneth L.	707/200
*	D	US-6,308,173	10-2001	Glasser et al.	707/9
*	E	US-2004/0098370	05-2004	Garland et al.	707/001
*	F	US-6,363,400	03-2002	Chtchetkine et al.	707/200
*	G	US-2002/0184357	12-2002	Traversat et al.	709/223
*	H	US-2004/0103280	05-2004	Balfanz et al.	713/169
*	I	US-2006/0129627	06-2006	Phillips et al.	709/200
*	J	US-2004/0177148	09-2004	Tsimelzon, Mark JR.	709/227
*	K	US-6,453,319	09-2002	Mattis et al.	707/100
*	L	US-2005/0149481	07-2005	Hesselink et al.	707/001
*	M	US-2005/0114672	05-2005	Duncan et al.	713/182

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/729,841		Applicant(s)/Patent Under Reexamination SAMJI ET AL.	
	Examiner Anh Ly		Art Unit 2162	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0046260	03-2003	Satyanarayanan et al.	707/1
*	B	US-2004/0019584	01-2004	Greening et al.	707/1
*	C	US-2003/0018712	01-2003	Harrow et al.	709/203
*	D	US-2004/0054674	03-2004	Carpenter et al.	707/009
*	E	US-6,662,198	12-2003	Satyanarayanan et al.	707/204
*	F	US-2004/0225650	11-2004	Cooper et al.	707/003
*	G	US-2005/0120242	06-2005	Mayer et al.	713/201
*	H	US-2006/0173873	08-2006	Prompt et al.	707/100
*	I	US-2003/0225796	12-2003	Matsubara, Daisuke	707/200
*	J	US-2004/0177148	09-2004	Tsimelzon, Mark JR.	709/227
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.